Application/Control No. 09/755,878 Examiner Tu X Nguyen Applicant(s)/Patent Under Reexamination MATSUDA ET AL. Art Unit Page 1 of 1

Notice of References Cited

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2001/0051536	12-2001	MURAMATSU, TOSHIHIKO	455/567
	В	US-RE37,281	07-2001	Motegi, Takamasa	340/636.15
	С	US-6,308,086	10-2001	Yoshino, Hideyuki	455/567
	D	US-6,463,278	10-2002	Kraft et al.	455/418
	E	US-6,175,721	01-2001	Hayato, Yasuo	340/7.58
	F	US-5,870,684	02-1999	Hoashi et al.	455/567
	G	US-5,771,001	06-1998	Cobb, Marlon J.	340/573.1
	Н	US-6,463,278	10-2002	Kraft et al.	455/418
	ł	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

_							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	u						
	V						
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.